μPD8253
PROGRAMMABLE INTERVAL TIMER

Description

The NEC μPD8253 contains three independent, programmable, multi-model 16-bit counter/timers. It is designed as a general purpose device, fully compatible with the 8080 family. The μPD8253 interfaces directly to the buses of the processor as an array of I/O ports.

The μPD8253 can generate accurate time delays under the control of system software. The three independent 16-bit counters can be clocked at rates from DC to 5 MHz. The system software controls the loading and starting of the counters to provide accurate multiple time delays. The counter output flags the processor at the completion of the time-out cycles.

System overhead is greatly improved by relieving the software from the maintenance of timing loops. Some other common uses for the μPD8253 in microprocessor based systems are:

- Programmable baud rate generator
- Event counter
- Binary rate multiplier
- Real time clock
- Digital one-shot
- Complex motor controller

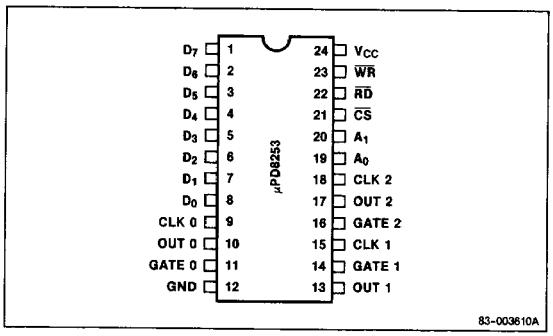
Features

- ☐ Three independent 16-bit counters
- ☐ Clock rate: DC to 5 MHz
- ☐ Binary count or BCD
- ☐ Single +5 V power supply, ±10%

Ordering Information

Part Number	Package Type	Max Frequency of Operation
μPD8253C-2	24-pin plastic DIP	5 MHz
μPD8253C-5	24-pin plastic DIP	4 MHz

Pin Configuration



Pin Identification

No.	Symbol	Function
1-8	D_7-D_0	Three-state data bus
9,15,18	CLK 0,1,2	Counter clock inputs 0-2
10,13,17	OUT 0,1,2	Counter outputs 0-2
11,14,16	GATE 0,1,2	Counter gate inputs 0-2
12	GND	Ground
19,20	A0,A1	Counter select
21	$\overline{CS}$	Chip select
22	$\overline{RD}$	Read counter
23	$\overline{WR}$	Write command or data
24	V_{CC}	+5 V power supply

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Pin Functions

D_7-D_0 (Data Bus)

These pins form a three-state, bidirectional data bus that interfaces with the 8080AF/8085 microprocessor system.

CLK 0,1,2 (Counter Clock Inputs 0-2)

CLK 0, CLK 1, and CLK 2 input the clock signal for counter 0, counter 1, and counter 2, respectively.

OUT 0,1,2 (Counter Outputs 0-2)

OUT 1, OUT 2, and OUT 3 are outputs signals for counter 0, counter 1, and counter 2, respectively.

GATE 0,1,2 (Counter Gate Inputs 0-2)

The GATE 0, GATE 1, and GATE 2 inputs gate counter 0, counter 1, and counter 2, respectively.

GND (Ground)

Connection to ground.

A_0, A_1 (Counter Select)

These inputs are normally connected to the processor's address bus. Their function is to select which of the three counters will be operated on, and to address the control word register for mode selection.

$\overline{CS}$ (Chip Select)

A low level input to this pin enables the μPD8253. Reading and writing will not occur unless the device is selected. This input has no effect on the actual operation of the counters.

$\overline{RD}$ (Read Counter)

A low level input to this pin instructs the μPD8253 to send the selected counter value to the processor.

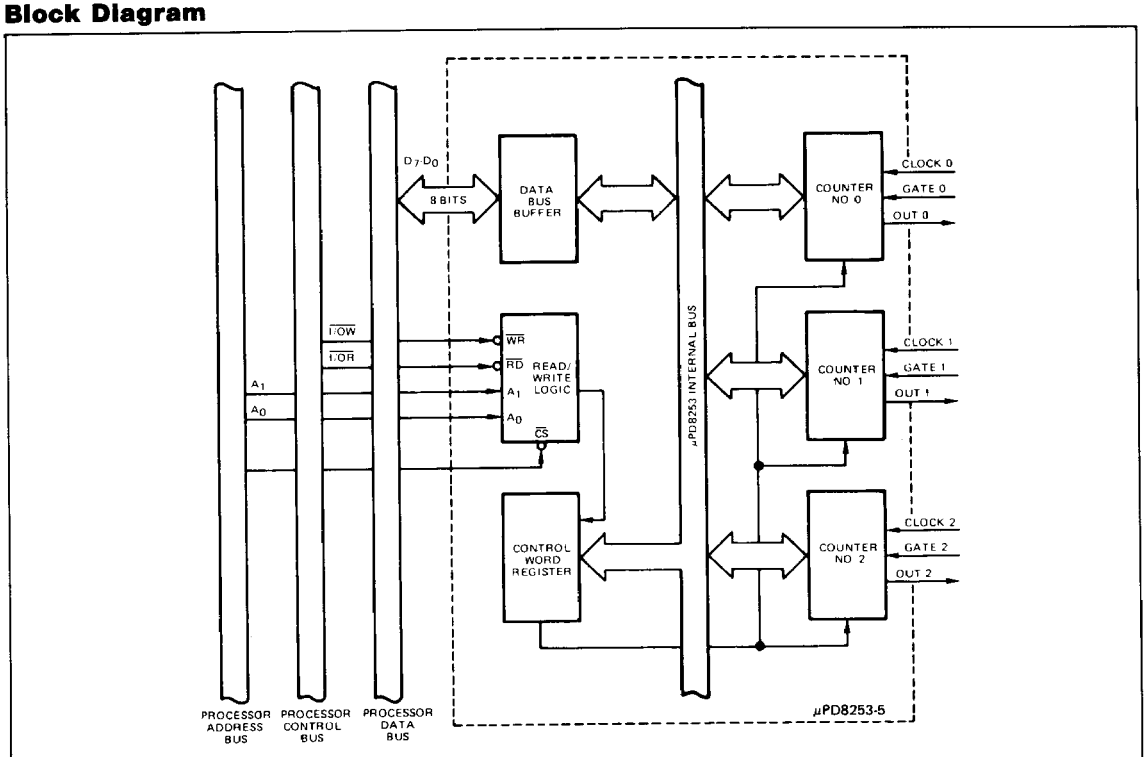
$\overline{WR}$ (Write Command or Data)

A low level input to this pin instructs the μPD8253 to receive mode information or counter input data from the processor.

V_{CC}

+5 V power supply.

Block Diagram



Functional Description

The three-state, bidirectional data bus buffer interfaces the μPD8253 to the 8080AF/8085A microprocessor system. Data transfer is according to the input or output instructions executed by the processor. The data bus buffer has three basic functions:

- Programming the μPD8253 modes
- Loading the count registers
- Reading the count values

The read/write logic controls the overall operation of the μPD8253 and is governed by inputs received from the processor system bus.

When A_0 and A_1 are high level, data from the data bus buffer is stored in the control word register. This data controls the operational mode of the counters, the selection of BCD or binary counting, and the loading of the count registers.

Counters 0, 1, and 2 are identical 16-bit down counters that are functionally independent, allowing for separate mode configurations and counting operations. Each counter can operate in either binary or BCD. Gate, input, and output line configurations are determined by the operational mode data stored in the control word register. System software overhead can be reduced by allowing the control word to govern the loading of the count data.

It is possible to read the contents of a counter when it is operating, without disturbing its operation. The following table shows how the counters are manipulated by input signals to the read/write logic.

$\overline{CS}$	$\overline{RD}$	$\overline{WR}$	A_1	A_0	Function
0	1	0	0	0	Load counter no. 0
0	1	0	0	1	Load counter no. 1
0	1	0	1	0	Load counter no. 2
0	1	0	1	1	Write mode word
0	0	1	0	0	Read counter no. 0
0	0	1	0	1	Read counter no. 1
0	0	1	1	0	Read counter no. 2
0	0	1	1	1	No-operation, 3-state
1	X	X	X	X	Disable, 3-state
0	1	1	X	X	No-operation, 3-state

Absolute Maximum Ratings

Operating temperature	0°C to +70°C
Storage temperature	−65°C to +150°C
Voltage on any pin	−0.5 to +7 volts (1)

Note:

(1) With respect to ground.

Comment: Exposing the device to stresses above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational sections of this specification. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Capacitance

T_A = 25°C; V_{CC} = GND = 0 V

Parameter	Symbol	Limits Min	Typ	Max	Unit	Test Conditions
Input capacitance	C_{IN}			10	pF	f_c = 1 MHz
Input/Output capacitance	$C_{I/O}$			20	pF	Unmeasured pins returned to V_{SS}

DC Characteristics

T_A = 0°C to +70°C; V_{CC} = +5 V ± 10%

Parameter	Symbol	Limits Min	Typ	Max	Unit	Test Conditions
Input low voltage	V_{IL}	−0.5		0.8	V	
Input high voltage	V_{IH} (1)	2.0		V_{CC} + 0.5	V	
Output low voltage	V_{OL}			0.45	V	I_{OL} = 2.2 mA
Output high voltage	V_{OH}	2.4			V	I_{OH} = −400 μA
Input load current	I_{IL}			±10	μA	$0 \le V_{IN} \le V_{CC}$
Output float leakage current	I_{OFL}			±10	μA	$0.45 \le V_{OUT} \le V_{CC}$
V_{CC} supply current	I_{CC}			140	mA	

Note:

(1) V_{IH} 2.2 min for μPD8253-2.

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AC Characteristics

T_A = 0°C to +70°C; V_{CC} = +5 V ±10%; GND = 0 V

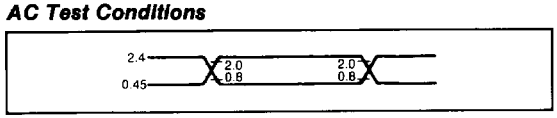
Parameter	Symbol	Limits μPD8253-2 Min	Limits μPD8253-2 Max	Limits μPD8253-5 Min	Limits μPD8253-5 Max	Unit	Test Conditions
Read							
Address stable before READ	t_{AR}	30		0		ns	
Address hold time for READ	t_{RA}	0		0		ns	
READ pulse width	t_{RR}	200		250		ns	
Data delay from READ	t_{RD}		140		170	ns	C_L = 150 pF
READ to data floating	t_{DF}	10	85	25	100	ns	C_L = 150 pF
Recovery time between READS	t_{RV}	200		1000		ns	
Write							
Address stable before WRITE	t_{AW}	0		0		ns	
Address hold time for WRITE	t_{WA}	0		0		ns	
WRITE pulse width	t_{WW}	160		250		ns	
Data set up time for WRITE	t_{DW}	130		150		ns	
Data hold time for WRITE	t_{WD}	0		0		ns	
Recovery time between WRITES	t_{RV}	200		1000		ns	
Clock and Gate Timing							
Clock period	t_{CLK}	200		250	DC	ns	
High pulse width	t_{PWH}	80		160		ns	
Low pulse width	t_{PWL}	80		90		ns	
Gate pulse width high	t_{GW}	120		150		ns	
Gate set up time to clock ↑	t_{GS}	70		100		ns	
Gate hold time after clock ↑	t_{GH}	50		50		ns	
Low gate width	t_{GL}	120		100		ns	
Output delay from Clock ↓	t_{OD}		250		300	ns	C_L = 150 pF
Output delay from gate	t_{ODG}		250		300	ns	C_L = 150 pF

Note:

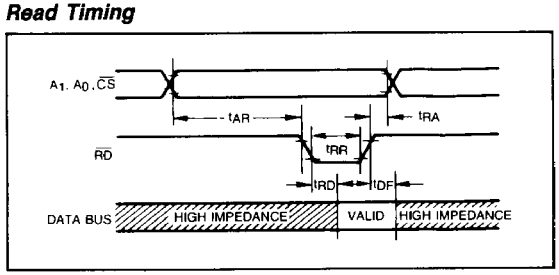
(1) AC timing measured at V_{OH} = 2.0 V; V_{OL} = 0.8 V.

Timing Waveforms

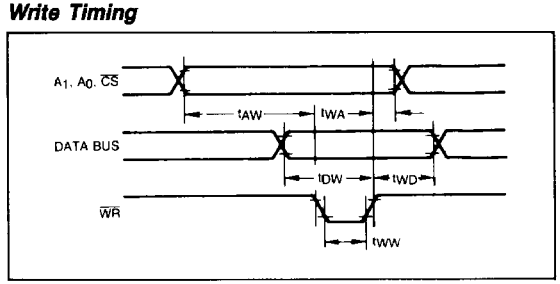
AC Test Conditions



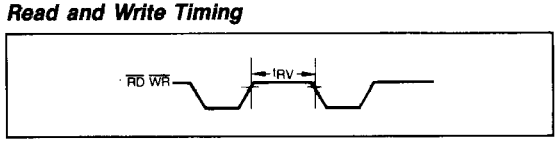
Read Timing



Write Timing

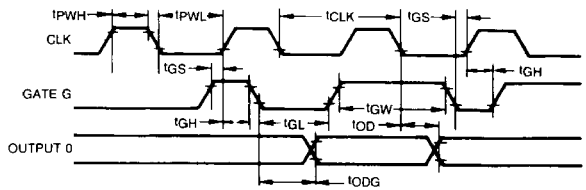


Read and Write Timing



Timing Waveforms (cont)

Clock and Gate Timing



Programming the μPD8253

The programmer can select any of the six operational MODES for the counters using system software. Individual counter programming is accomplished by loading the CONTROL WORD REGISTER with the appropriate control word data (A_0, A_1 = 11).

Control Word Format

D_7	D_6	D_5	D_4	D_3	D_2	D_1	D_0
SC_1	SC_0	RL_1	RL_0	M_2	M_1	M_0	BCD

RL — Read/Load

RL_1	RL_0	
0	0	Counter latching operation
1	0	Read/Load most significant byte only
0	1	Read/Load least significant byte only
1	1	Read/Load least significant byte first, then most significant byte

SC — Select Counter

SC_1	SC_0	
0	0	Select counter 0
0	1	Select counter 1
1	0	Select counter 2
1	1	Invalid

BCD

0	Binary counter, 16-bits
1	BCD counter, 4-decades

M-Mode

M_2	M_1	M_0	
0	0	0	Mode 0
0	0	1	Mode 1
X	1	0	Mode 2
X	1	1	Mode 3
1	0	0	Mode 4
1	0	1	Mode 5

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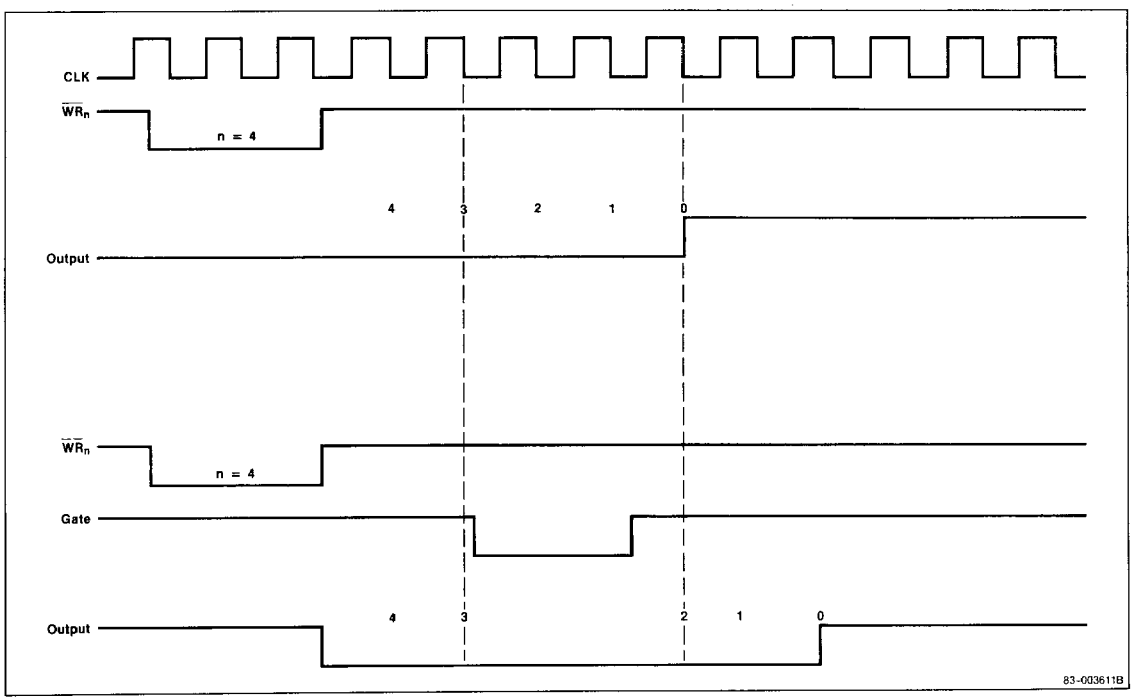
Operational Modes

Each of the three counters can be individually programmed with different operating MODES by appropriately formatted control words. The following is a summary of the MODE operations.

Mode O: Interrupt on Terminal Count

The initial MODE set operation forces the OUTPUT low. When the specified counter is loaded with the count value, it will begin counting. The OUTPUT will remain low until the terminal count sets it high. It will remain in the high state until the trailing edge of the second WR pulse loads in COUNT data. If data is loaded during the counting process, the first WR stops the count. Counting starts with the new count data triggered by the falling clock edge after the second WR. If a GATE pulse is asserted while counting, the count is terminated for the duration of GATE. The falling edge of CLK following the removal of GATE restarts counting from the terminated point.

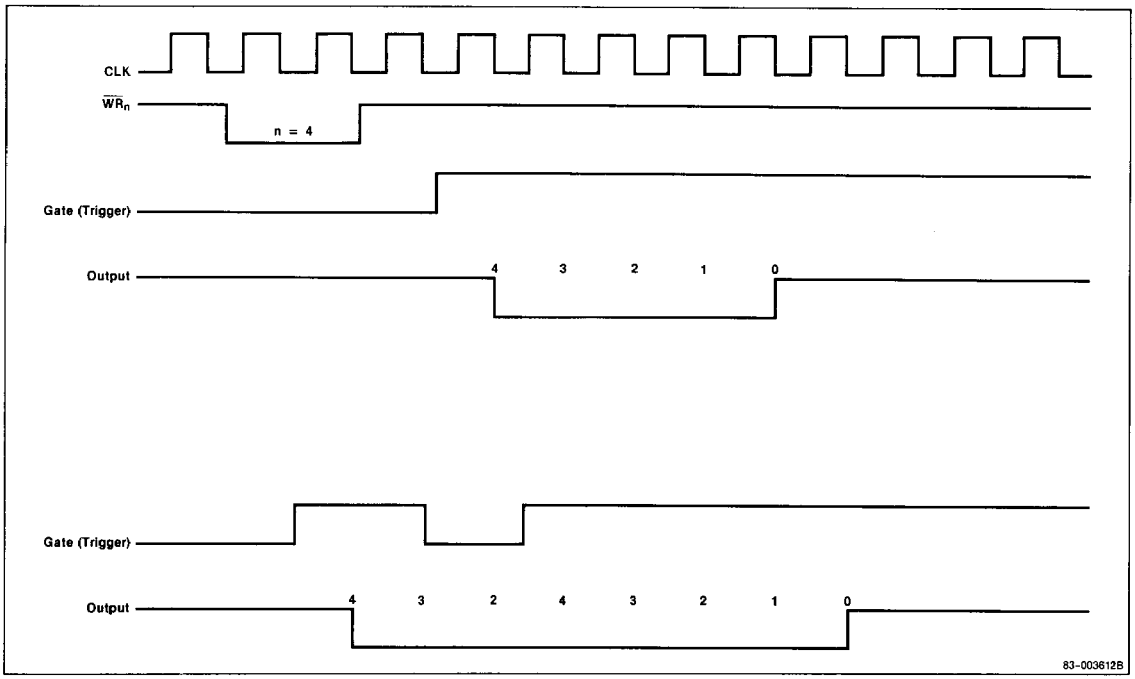
Mode 0: Interrupt on Terminal Count



Mode 1: Programmable One-Shot

The OUTPUT is set low by the falling edge of CLOCK following the trailing edge of GATE. The OUTPUT is set high again at the terminal count. The output pulse is not affected if new count data is loaded while the OUTPUT is low. The new data will be loaded on the rising edge of the next trigger pulse. The assertion of a trigger pulse while OUTPUT is low, resets and retriggers the one-shot. The OUTPUT will remain low for the full count value after the rising edge of TRIGGER.

Mode 1: Programmable One-Shot

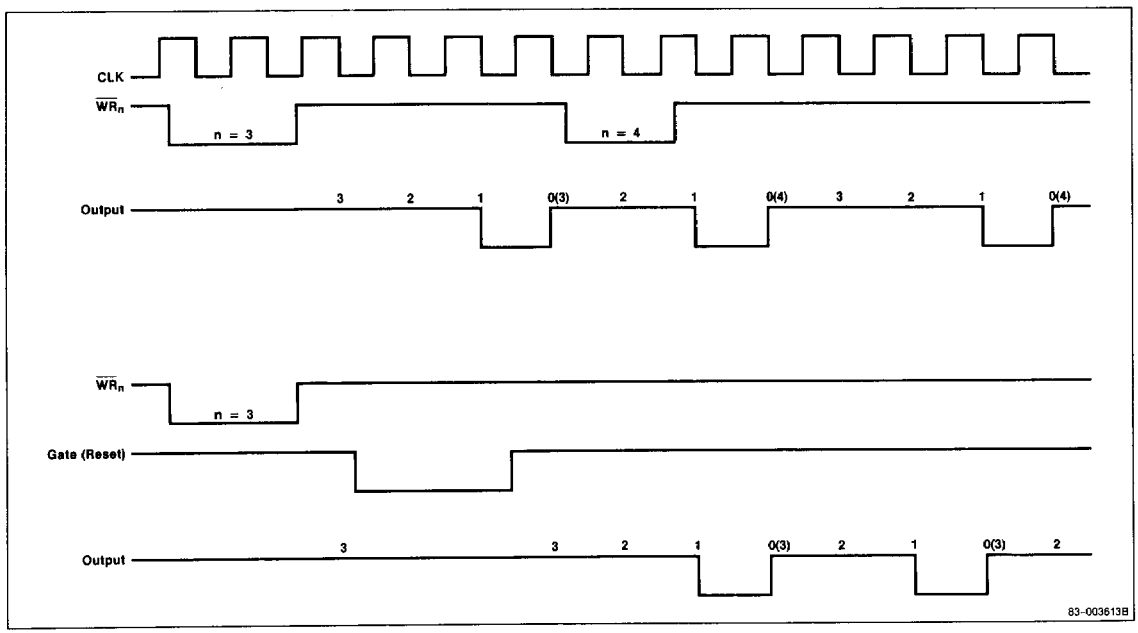


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Mode 2: Rate Generator

The RATE GENERATOR is a variable modulus counter. The OUTPUT goes low for one full CLOCK period as shown in the following timing diagram. The count data sets the time between OUTPUT pulses. If the count register is reloaded between output pulses the present period will not be affected. The subsequent period will reflect the new value. The OUTPUT will remain high for the duration of the asserted GATE input. Normal operation resumes on the falling CLOCK edge following the rising edge of GATE.

Mode 2: Rate Generator

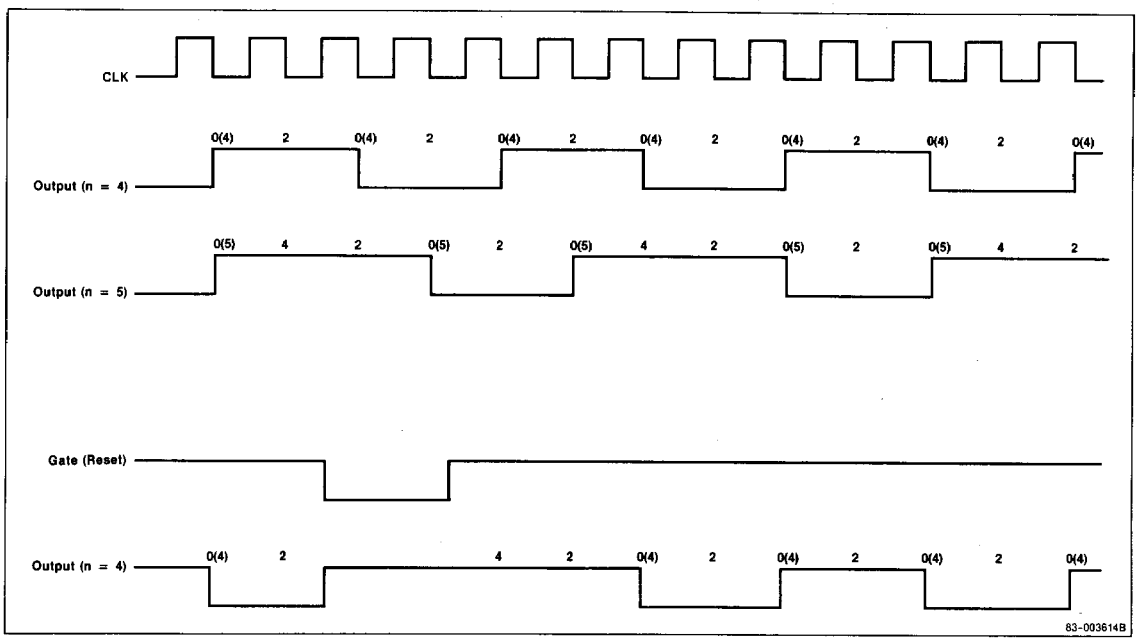


Mode 3: Square Wave Generator

MODE 3 resembles MODE 2 except the OUTPUT will be high for half of the count and low for the other half (for even values of data). For odd values of count data the OUTPUT. Put will be high one clock cycle longer than when it is low (High Period → $\frac{N+1}{2}$ clock cycles; Low Period → $\frac{N-1}{2}$ clock periods, where N is the decimal value of count data). If the count register is reloaded with a new value during counting, the new value will be reflected immediately after the output transition of the current count.

The OUTPUT will be held in the high state while GATE is asserted. Counting will start from the full count data after the GATE has been removed.

Mode 3: Square Wave Generator



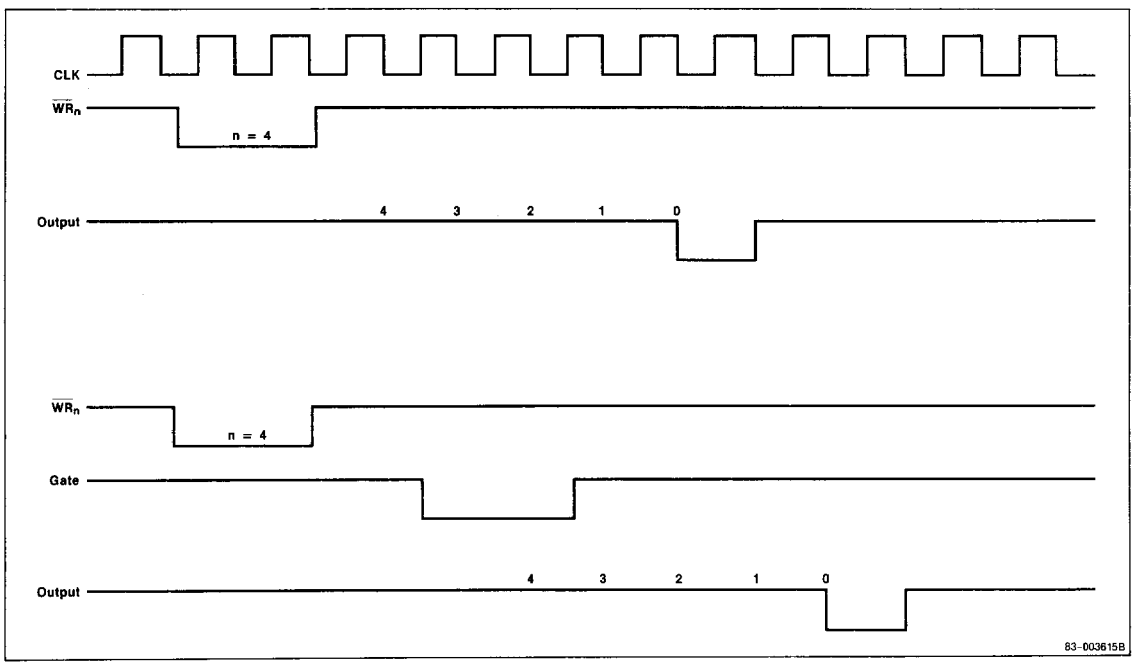
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Mode 4: Software Triggered Strobe

The OUTPUT goes high when MODE 4 is set, and counting begins after the second byte of data has been loaded. When the terminal count is reached, the OUTPUT will pulse low for one clock period. Changes in count data are reflected in the OUTPUT as soon as the new data has been loaded into the count registers. During the loading of new data, the OUTPUT is held high and counting is inhibited.

The OUTPUT is held high for the duration of GATE. The counters are reset and counting begins from the full data value after GATE is removed.

Mode 4: Software Triggered Strobe



Mode 5: Hardware Triggered Strobe

Loading MODE 5 sets OUTPUT high. Counting begins when count data is loaded and GATE goes high. After terminal count is reached, the OUTPUT will pulse low for one clock period. Subsequent trigger pulses will restart the counting sequence with the OUTPUT pulsing low on terminal count following the last rising edge of the trigger input. (Reference the bottom half of the timing diagram.)

Mode 5: Hardware Triggered Strobe

